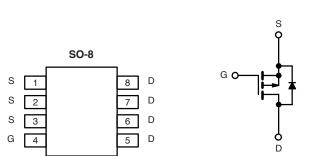


P-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)			
- 40	0.010 at V _{GS} = - 10 V	- 16.1	33 nC			
	0.014 at V _{GS} = - 4.5 V	- 13.3	33 110			



Top View

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- 100 % R_g Tested
- · 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC



ROHS COMPLIANT HALOGEN FREE

APPLICATIONS

- Load Switch
- POL

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	- 40	V	
Gate-Source Voltage		V_{GS}	± 20	V	
	T _C = 25 °C		- 16.1		
Continuous Drain Correct /T. 450 9C)	T _C = 70 °C	1 . [- 12.9		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	l _D	- 10.2 ^{b, c}		
	T _A = 70 °C		- 8.2 ^{b, c}	^	
Pulsed Drain Current		I _{DM}	- 50	A	
	T _C = 25 °C		- 5.3		
Continous Source-Drain Diode Current	T _A = 25 °C	l _S –	- 2.1 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	- 28		
Single Pulse Avalanche Energy		E _{AS}	39	mJ	
	T _C = 25 °C		6.3		
Mandagora Barras Bioglio alica	T _C = 70 °C		4		
Maximum Power Dissipation	T _A = 25 °C	P _D	2.5 ^{b, c}	W	
	T _A = 70 °C	†	1.6 ^{b, c}		
Operating Junction and Storage Temperature	T _J , T _{stg}	- 55 to 150	°C		

P-Channel MOSFET

THERMAL RESISTANCE RATINGS								
Parameter	Symbol	Typical	Maximum	Unit				
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	37	50	°C/W			
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	16	20	O/VV			

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 85 $^{\circ}\text{C/W}.$



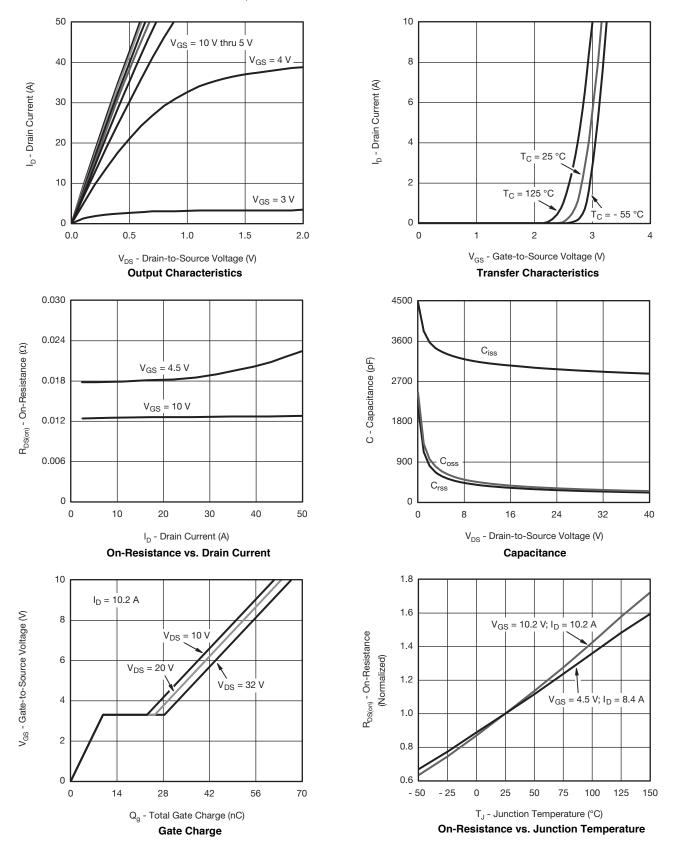
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					L		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, I}_{D} = -250 \mu\text{A}$	- 40			٧	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050		- 36		mV/°0	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_{D} = -250 \mu\text{A}$		5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$	- 1.2		- 2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Oata Wallana Busin Ouwant	I _{DSS}	V _{DS} = - 40 V, V _{GS} = 0 V			- 1		
Zero Gate Voltage Drain Current		V _{DS} = - 40 V, V _{GS} = 0 V, T _J = 55 °C	55 °C		- 5	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 25			Α	
Due in Course On Otata Danistana a	В	V _{GS} = - 10 V, I _D = - 10.2 A	0.010			1	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 8.4 A		0.014		Ω	
Forward Transconductance ^a	g _{fs}	V _{DS} = - 15 V, I _D = - 10.2 A		37		S	
Dynamic ^b					l		
Input Capacitance	C _{iss}			3007			
Output Capacitance	C _{oss}	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		335		pF	
Reverse Transfer Capacitance	C _{rss}			291			
Total Gate Charge		V _{DS} = - 20 V, V _{GS} = - 10 V, I _D = - 10.2 A	64	95			
				33	50	nC	
Gate-Source Charge	Q_{gs}	$V_{DS} = -20 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -10.2 \text{ A}$		9.8			
Gate-Drain Charge	Q _{gd}			15.7			
Gate Resistance	R_g	f = 1 MHz	0.4	2	4	Ω	
Turn-On Delay Time	t _{d(on)}			57	86		
Rise Time	t _r	V_{DD} = - 20 V, R_L = 2.4 Ω		50	75		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 8.2 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		40	60		
Fall Time	t _f			17	26	no	
Turn-On Delay Time	t _{d(on)}			13	20	ns	
Rise Time	t _r	V_{DD} = - 20 V, R_L = 2.4 Ω		11	20	- -	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 8.2 A, V_{GEN} = - 10 V, R_g = 1 Ω		45	68		
Fall Time	t _f			9	18		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 5.3	Α	
Pulse Diode Forward Current	I _{SM}				- 50		
Body Diode Voltage	V_{SD}	I _S = -8.2 A, V _{GS} = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}	I _F = - 8.2 A, dl/dt = 100 A/μs, T _J = 25 °C		36	54	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			41	62	nC	
Reverse Recovery Fall Time	t _a			20		nc	
Reverse Recovery Rise Time	t _b]		16		ns	

Notes:

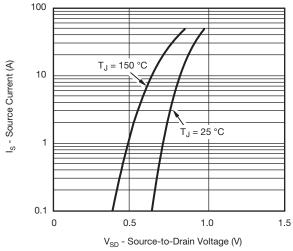
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

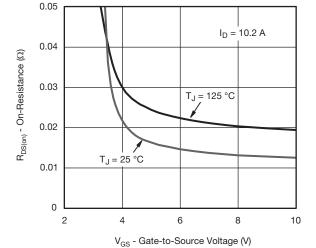
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



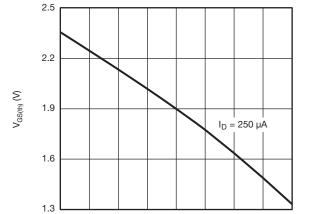




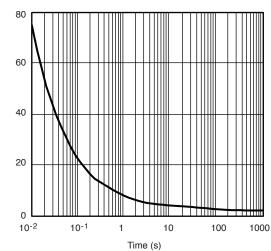




Source-Drain Diode Forward Voltage



On-Resistance vs. Gate-to-Source Voltage



T_J - Temperature (°C) Threshold Voltage

50

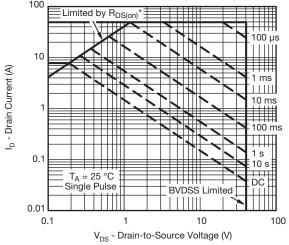
75

100

125

150

Single Pulse Power (Junction-to-Ambient)



Power (W)

 * V_{GS} > minimum V_{GS} at which $R_{\text{DS(on)}}$ is specified

Safe Operating Area, Junction-to-Ambient

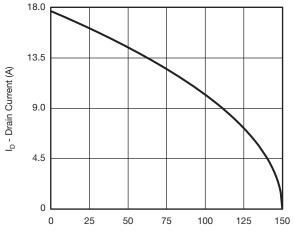
- 50

- 25

0

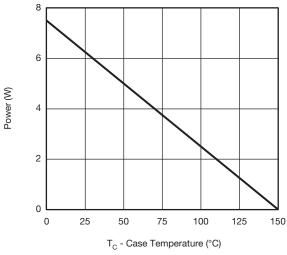
25

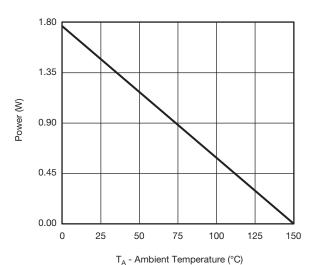




 T_{C} - Case Temperature (°C)

Current Derating*



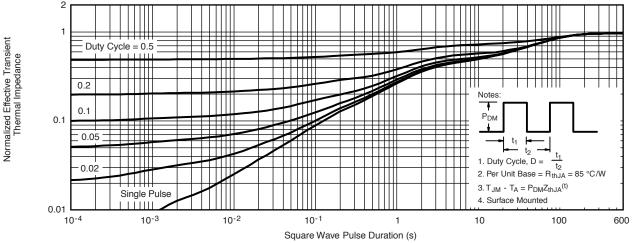


Power, Junction-to-Foot

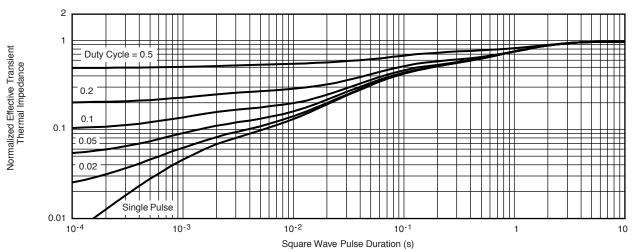
Power, Junction-to-Ambient

 $^{^{\}star}$ The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





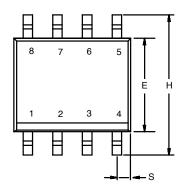
Normalized Thermal Transient Impedance, Junction-to-Ambient

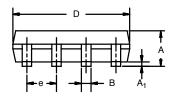


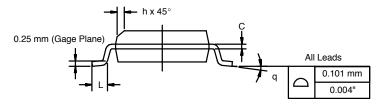
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEADJEDEC Part Number: MS-012







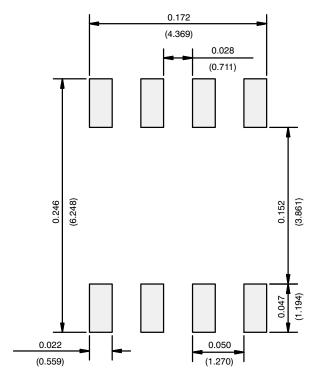
	MILLIM	IETERS	INCHES			
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050	0.050 BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
FCN: C-06527-Rev 11-Sen-06						

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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